

LINEAR SYSTEMS

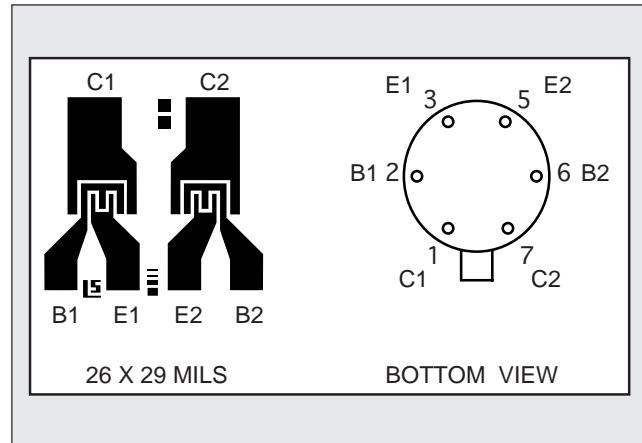
Linear Integrated Systems

LS350 LS351 LS352

MONOLITHIC DUAL PNP TRANSISTORS

FEATURES

HIGH GAIN	$h_{FE} \geq 200 @ 10\mu A - 1mA$			
TIGHT V_{BE} MATCHING	$ V_{BE1}-V_{BE2} = 0.2mV TYP.$			
HIGH f_T	275MHz TYP. @ 1mA			
ABSOLUTE MAXIMUM RATINGS NOTE 1				
@ 25°C (unless otherwise noted)				
I_C	Collector Current	10mA		
Maximum Temperatures				
Storage Temperature	-65° to +200°C			
Operating Junction Temperature	+150°C			
Maximum Power Dissipation				
Device Dissipation @ Free Air	250mW	500mW		
Linear Derating Factor	2.3mW/°C	4.3mW/°C		

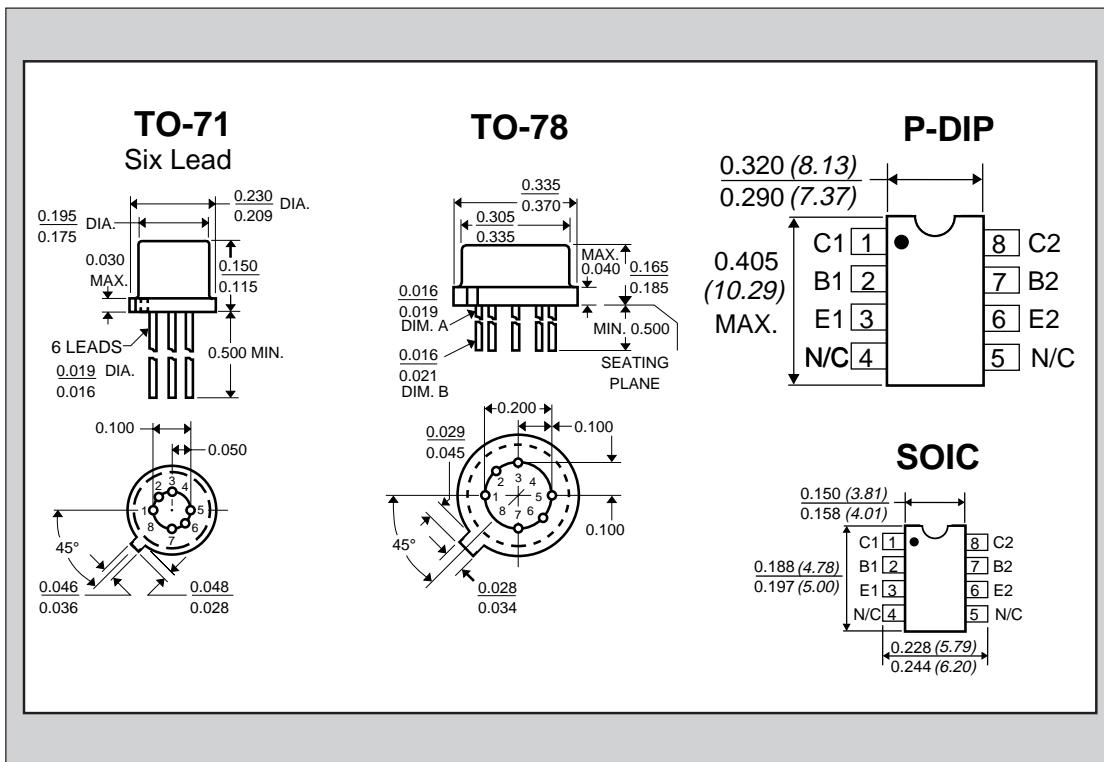


ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTICS	LS350	LS351	LS352		UNITS	CONDITIONS
BV_{CBO}	Collector to Base Voltage	25	45	60	MIN.	V	$I_C = 10\mu A$ $I_E = 0$
BV_{CEO}	Collector to Emitter Voltage	25	45	60	MIN.	V	$I_C = 10\mu A$ $I_B = 0$
BV_{EBO}	Emitter to Base Voltage	6.2	6.2	6.2	MIN.	V	$I_E = 10\mu A$ $I_C = 0$ NOTE 2
BV_{CCO}	Collector to Collector Voltage	30	60	100	MIN.	V	$I_C = 10\mu A$ $I_E = 0$
h_{FE}	DC Current Gain	100 600	150 600	200 600	MIN. MAX.		$I_C = 10\mu A$ $V_{CE} = 5V$
h_{FE}	DC Current Gain	100 600	150 600	200 600	MIN. MAX.		$I_C = 100\mu A$ $V_{CE} = 5V$
h_{FE}	DC Current Gain	100	150	200	MIN.		$I_C = 1mA$, $V_{CE} = 5V$
$V_{CE(SAT)}$	Collector Saturation Voltage	0.5	0.5	0.5	MAX.	V	$I_C = 1mA$ $I_B = 0.1mA$
I_{CBO}	Collector Cutoff Current	0.2	0.2	0.2	MAX.	nA	$I_E = 0$ $V_{CB} = $ NOTE 3
I_{EBO}	Emitter Cutoff Current	0.2	0.2	0.2	MAX.	nA	$I_C = 0$ $V_{EB} = 3V$
C_{OBO}	Output Capacitance	2	2	2	MAX.	pF	$I_E = 0$ $V_{CB} = 5V$
C_{C1C2}	Collector to Collector Capacitance	2	2	2	MAX.	pF	$V_{CC} = 0$
I_{C1C2}	Collector to Collector Leakage Current	0.5	0.5	0.5	MAX.	nA	$V_{CC} = $ NOTE4
f_T	Current Gain Bandwidth Product	200	200	200	MIN.	MHz	$I_C = 1mA$ $V_{CE} = 5V$
NF	Narrow Band Noise Figure	3	3	3	MAX.	dB	$I_C = 100\mu A$ $V_{CE} = 5V$ $BW = 200Hz$ $R_G = 10 K\Omega$ $f = 1KHz$

MATCHING CHARACTERISTICS

SYMBOL	CHARACTERISTICS	LS350	LS351	LS352	UNITS	CONDITIONS
$ V_{BE1} - V_{BE2} $	Base Emitter Voltage Differential	1 5	0.4 1.0	0.2 0.5	TYP. MAX.	mV mV
$\Delta(V_{BE1} - V_{BE2})/{}^{\circ}\text{C}$	Base Emitter Voltage Differential Change with Temperature	2 20	1 10	0.5 2	TYP. MAX.	$\mu\text{V}/{}^{\circ}\text{C}$ $\mu\text{V}/{}^{\circ}\text{C}$
$ I_{B1} - I_{B2} $	Base Current Differential		5	5	MAX.	nA
$ \Delta(I_{B1} - I_{B2}) /{}^{\circ}\text{C}$	Base Current Differential Change with Temperature		0.5	0.3	MAX.	nA/ ${}^{\circ}\text{C}$
h_{FE1}/h_{FE2}	DC Current Gain Differential	10	5	5	TYP.	%
						$I_C = 10 \mu\text{A}$ $V_{CE} = 5\text{V}$



NOTES:

1. These ratings are limiting values above which the serviceability of any semiconductor may be impaired.
2. The reverse base-to-emitter voltage must never exceed 6.2 volts; the reverse base-to-emitter current must never exceed 10 μA .
3. For LS350: $V_{CB} = 20\text{V}$; for LS351 & LS352: $V_{CB} = 30\text{V}$.
4. For LS351: $V_{CC} = \pm 45\text{V}$; for LS352: $V_{CC} = \pm 80\text{V}$; for LS350: $V_{CC} = \pm 25\text{V}$.